

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/645,425		DECKERS ET AL.	
Examiner				Art Unit			
Rip A. Lee				1713			

ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
526	160	526	161	170	172	134	126	144		
INTERNATIONAL CLASSIFICATION										
C	0	8	F	4/76						
C	0	8	F	4/52						
C	0	8	F	4/64						
C	0	8	F	4/642						
				/						
 (Assistant Examiner) AUG 16 2005 (Date)				 DAVID W. WU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner) S/17/05 (Date)					Total Claims Allowed: 15	
(Legal Instruments Examiner) (Date)									O.G. Print Claim(s) 1	O.G. Print Fig.

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
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15		45	75	105	135	165	195
16		46	76	106	136	166	196
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19		49	79	109	139	169	199
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21		51	81	111	141	171	201
22		52	82	112	142	172	202
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25		55	85	115	145	175	205
26		56	86	116	146	176	206
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